## Application/Control No. Applicant(s)/Patent Under Reexamination 10/799,081 ABE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1751 John R. Hardee **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0144356 10-2002 8/405 Α Kawai et al. US-В С US-US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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